

Serial EEPROM Series Standard EEPROM WLCSP EEPROM



BRCC016GWX-3

●General Description

BRCC016GWX-3 is a serial EEPROM of I²C BUS interface method

●Features

- Completely conforming to the world standard I²C BUS.
All controls available by 2 ports of serial clock (SCL) and serial data (SDA)
- 1.7V to 3.6V single power source action most suitable for battery use
- 1.7V to 3.6V wide limit of action voltage, possible FAST MODE 400KHz action
- 16byte page write mode useful for initial value write at factory shipment
- Auto erase and auto end function at data write
- Low current consumption
- Write mistake prevention function at low voltage
- Data rewrite up to 1,000,000 times
- Data kept for 40 years
- Noise filter built in SCL / SDA terminal
- Pull-up resistor built in WP terminal
- Shipment data all address FFh

●Packages W(Typ.) x D(Typ.) x H(Max.)

UCSP16X1 1.30mm × 0.77 mm × 0.20mm

●BRCC016GWX-3

Capacity	Bit format	Type	Power source voltage	Package
16Kbit	2K×8	BRCC016GWX-3	1.7~3.6V	UCSP16X1

●Absolute Maximum Ratings (Ta=25°C)

Parameter	Symbol	Ratings	Unit	Remarks
Supply Voltage	V _{CC}	-0.3 to +6.5	V	
Power Dissipation	P _d	220 (UCSP16X1)	mW	When using at Ta=25°C or higher 2.2mW to be reduced per 1°C.
Storage Temperature	T _{stg}	-65 to +125	°C	
Operating Temperature	T _{opr}	-40 to +85	°C	
Terminal Voltage	-	-0.3 to V _{CC} +1.0	V	Because WP is pulled up, current flows to V _{CC} by applying a voltage greater than V _{CC}

●Memory Cell Characteristics (Ta=25°C, V_{CC}=1.7V to 3.6V)

Parameter	Limits			Unit
	Min.	Typ.	Max	
Number of data rewrite times *1	1,000,000	—	—	Times
Data hold years *1	40	—	—	Years

*1Not 100% TESTED

●Recommended Operating Ratings

Parameter	Symbol	Ratings	Unit
Power source voltage	V _{CC}	1.7 to 3.6	V
Input voltage	V _{IN}	0 to V _{CC}	

●Electrical Characteristics (Unless otherwise specified, Ta=-40 to +85°C, V_{CC}=1.7V to 3.6V)

Parameter	Symbol	Limits			Unit	Conditions
		Min.	Typ.	Max.		
"H" Input Voltage1	VIH1	0.8V _{CC}	—	V _{CC} +1.0	V	1.7V ≤ V _{CC} ≤ 3.6V (SDA,SCL)
"H" Input Voltage2	VIH2	0.8V _{CC}	—	V _{CC} +0.3	V	1.7V ≤ V _{CC} ≤ 3.6V (WP)
"L" Input Voltage	VIL	-0.3	—	0.2V _{CC}	V	1.7V ≤ V _{CC} ≤ 3.6V
"L" Output Voltage1	VOL1	—	—	0.4	V	IOL=3.0mA, 2.5V ≤ V _{CC} ≤ 3.6V (SDA)
"L" Output Voltage2	VOL2	—	—	0.2	V	IOL=0.7mA, 1.7V ≤ V _{CC} < 2.5V (SDA)
Input Leakage Current	ILI	-1	—	1	μA	VIN=0 to V _{CC}
Pull-up resistor	Rpu	3	5	7	kΩ	(WP)
Output Leakage Current	ILO	-1	—	1	μA	VOUT=0 to V _{CC} (SDA)
Operating Current	ICC1	—	—	2.0	mA	V _{CC} =3.6V, fSCL=400kHz, tWR=5ms, Byte write, Page write
	ICC2	—	—	0.5	mA	V _{CC} =3.6V, fSCL=400kHz Random read, current read, sequential read WP=OPEN
Standby Current	ISB	—	—	2.0	μA	V _{CC} =3.6V, SDA · SCL=V _{CC} , WP=OPEN

●Action Timing Characteristics (Unless otherwise specified, Ta=−40 to +85°C, Vcc=1.7V to 3.6V)

Parameter	Symbol	Limits			Unit
		Min.	Typ.	Max.	
Clock Frequency	fSCL	—	—	400	kHz
Data Clock High Period	tHIGH	0.6	—	—	μs
Data Clock Low Period	tLOW	1.2	—	—	μs
SDA and SCL Rise Time *1	tR	—	—	0.3	μs
SDA and SCL Fall Time *1	tF	—	—	0.3	μs
Start Condition Hold Time	tHD:STA	0.6	—	—	μs
Start Condition Setup Time	tSU:STA	0.6	—	—	μs
Input Data Hold Time	tHD:DAT	0	—	—	ns
Input Data Setup Time	tSU:DAT	100	—	—	ns
Output Data Delay Time	tPD	0.1	—	0.9	μs
Output Data Hold Time	tDH	0.1	—	—	μs
Stop Condition Setup Time	tSU:STO	0.6	—	—	μs
Bus Free Time	tBUF	1.2	—	—	μs
Write Cycle Time	tWR	—	—	5	ms
Noise Spike Width (SDA and SCL)	tl	—	—	0.1	μs

*1 Not 100% TESTED.

Condition Input data level: VIL=0.2×Vcc VIH=0.8×Vcc

Input data timing reference level: 0.3×Vcc/0.7×Vcc

Output data timing reference level: 0.3×Vcc/0.7×Vcc

Rise/Fall time : ≤20ns

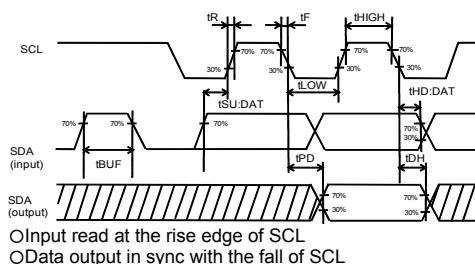
●Sync Data Input / Output Timing


Figure 1-(a). Sync data input / output timing

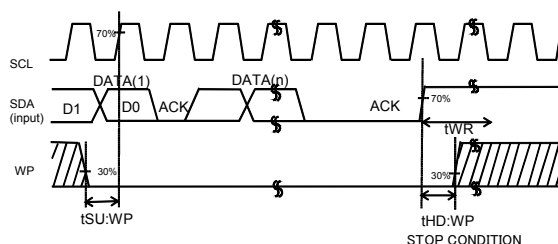


Figure 1-(d). WP timing at write execution

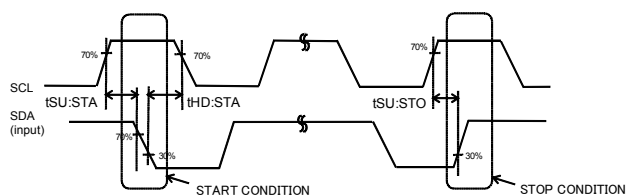


Figure 1-(b). Start-stop bit timing

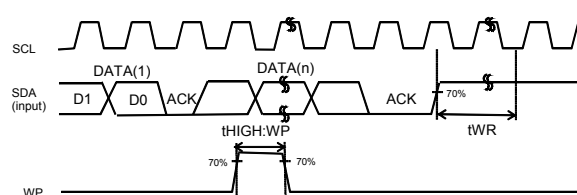


Figure 1-(e). WP timing at write cancel

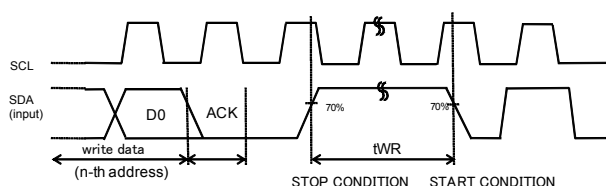


Figure 1-(c). Write cycle timing

●Block Diagram

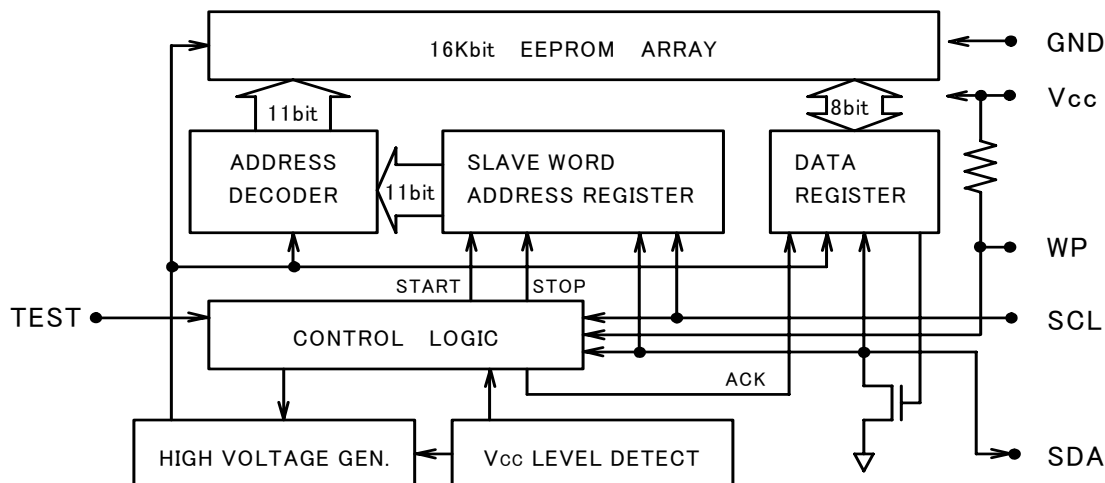
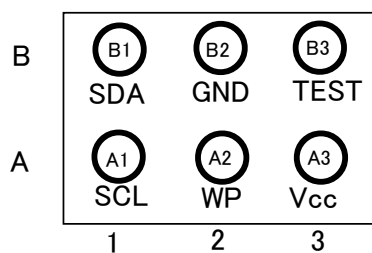


Figure 2. Block diagram

●Pin Configuration



bottom view

●Pin Configuration and Description

Land No.	Terminal Name	Input / Output	Unit
B3	TEST	Input	Connect Vcc
B2	GND	—	Reference voltage of all input / output, 0V
B1	SDA	Input / Output	Slave and word address, Serial data input serial data output
A3	Vcc	—	Power Supply
A2	WP	Input	Write protect terminal
A1	SCL	Input	Serial clock input

● Typical Performance Curves

(The following values are Typ. ones.)

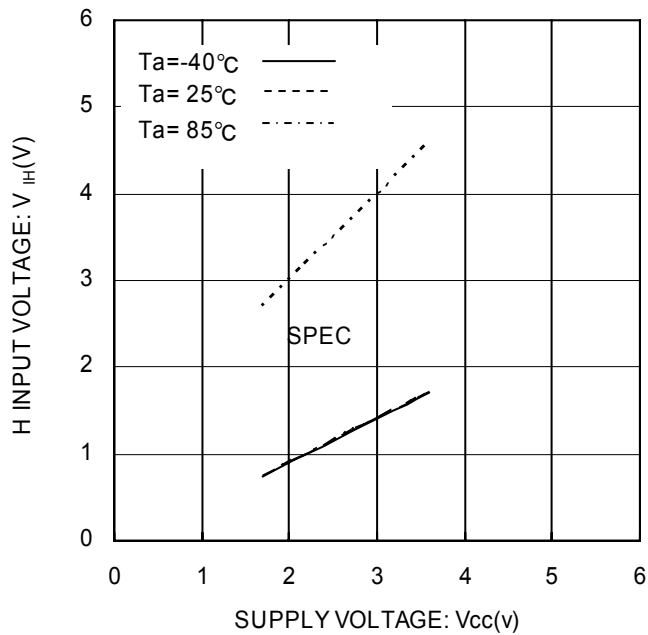


Figure 3. 'H' input voltage V_{IH}
(SCL, SDA, WP)

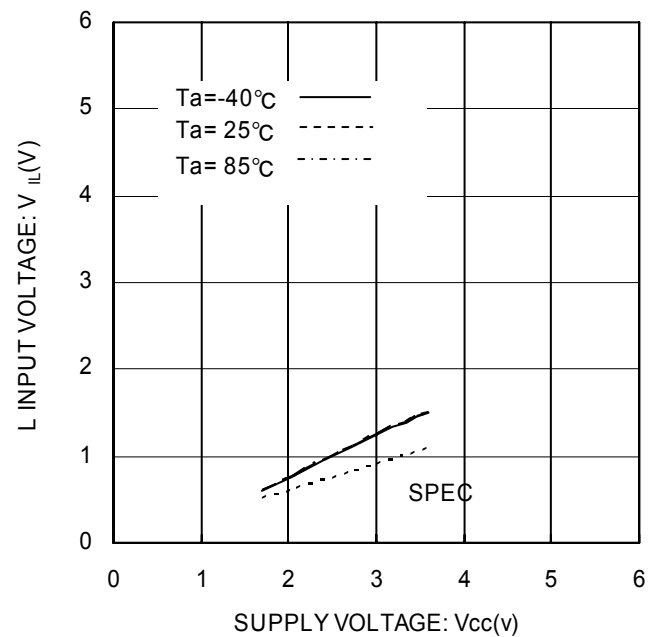


Figure 4. 'L' input voltage V_{IL}
(SCL, SDA, WP)

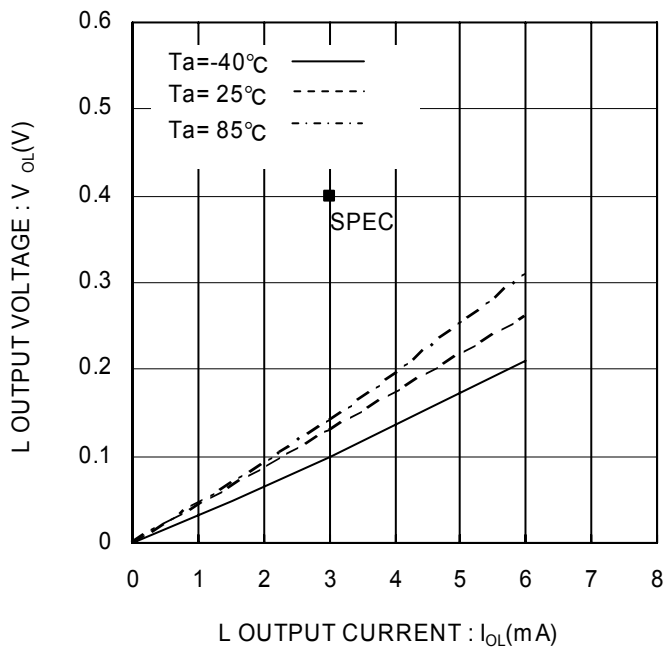


Figure 5. 'L' output voltage $V_{OL-I_{OL}}$ ($V_{CC}=1.7V$)

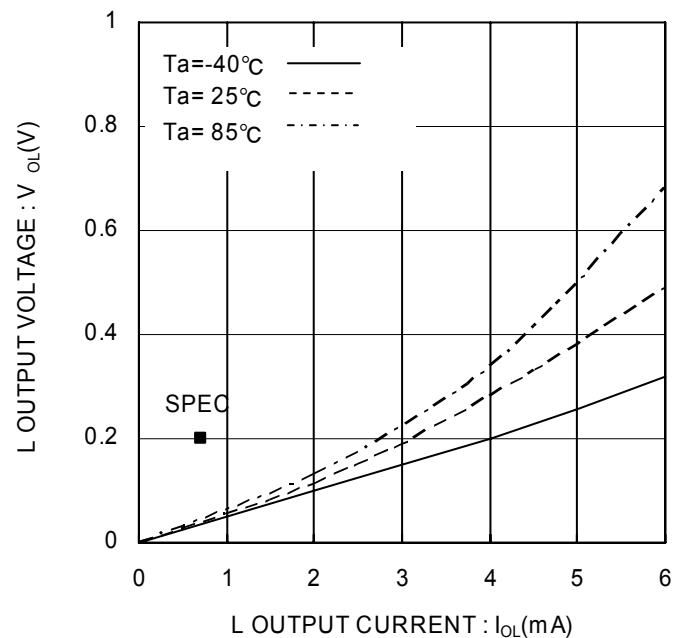


Figure 6. 'L' output voltage $V_{OL-I_{OL}}$ ($V_{CC}=2.5V$)

● Typical Performance Curves - Continued

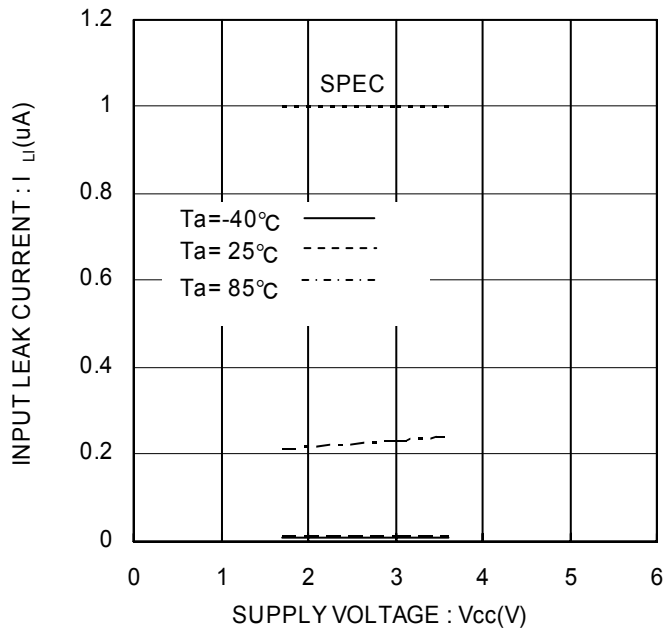


Figure 7. Input leak current $I_{LI}(SCL)$

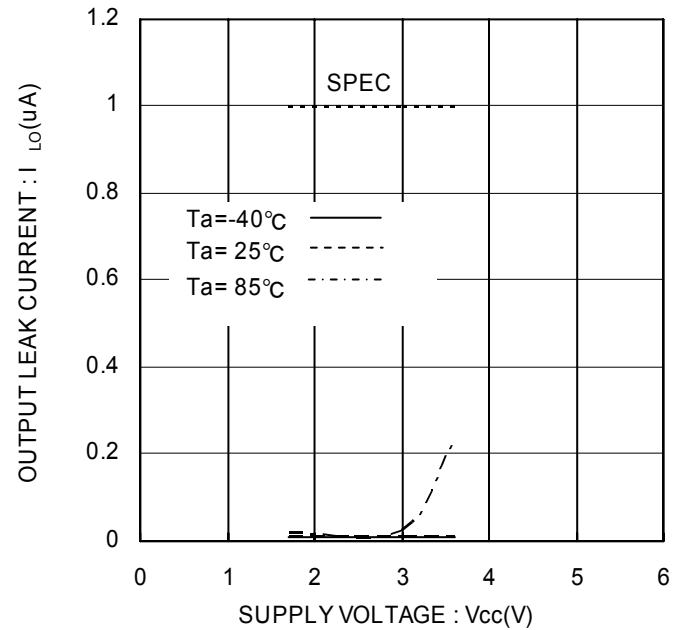


Figure 8. Output leak current $I_{LO}(SDA)$

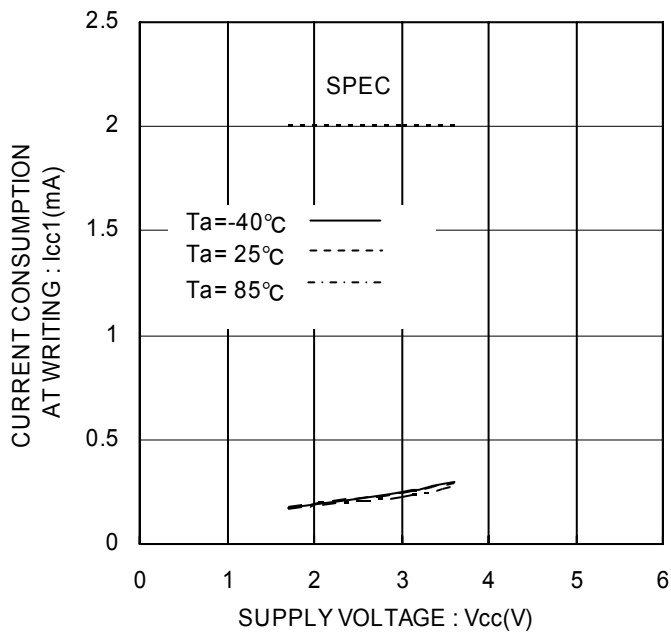


Figure 9. Current consumption at WRITE operation I_{cc1}
(fsc1=400kHz)

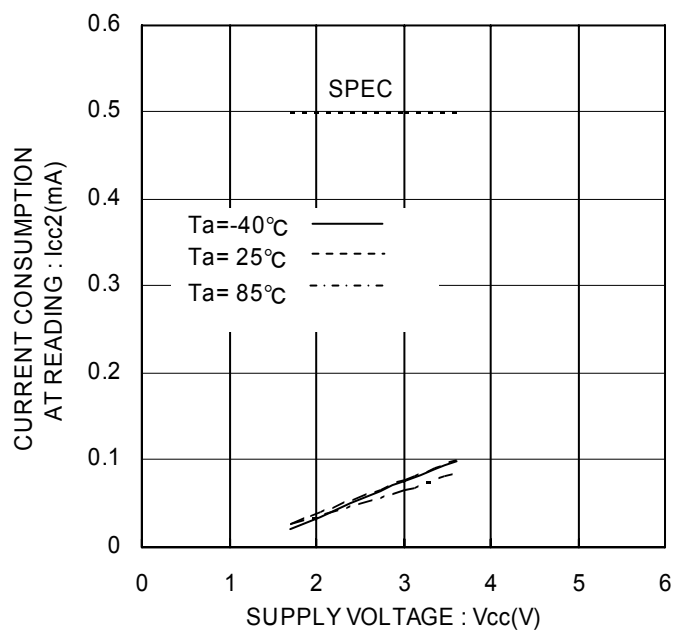


Figure 10. Current consumption at READ operation I_{cc2}
(fsc1=400kHz)

●Typical Performance Curves - Continued

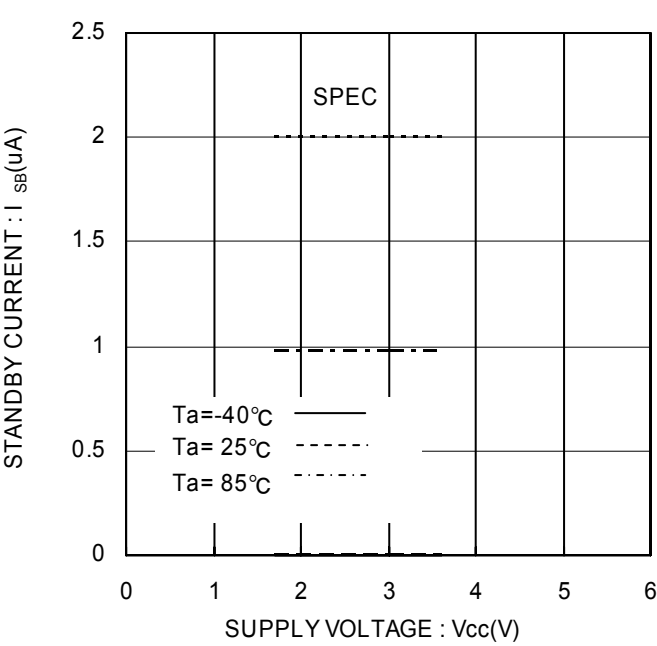


Figure 11. Standby operation I_{SB}

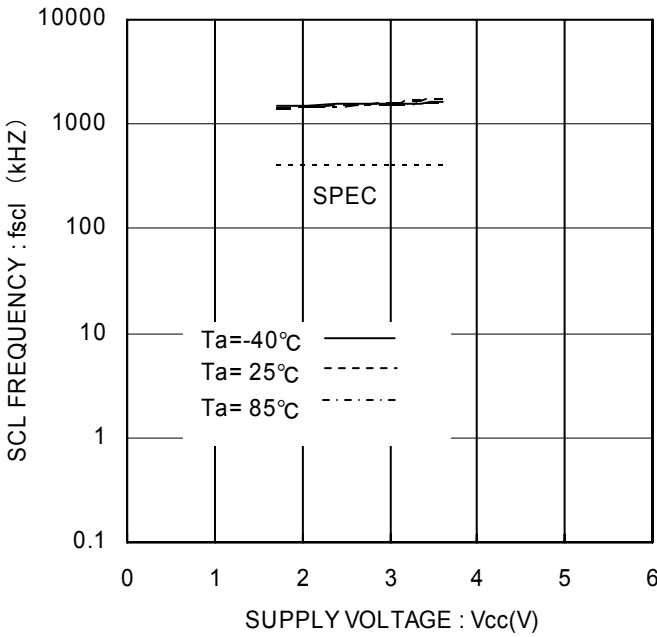


Figure 12. SCL frequency f_{SCL}

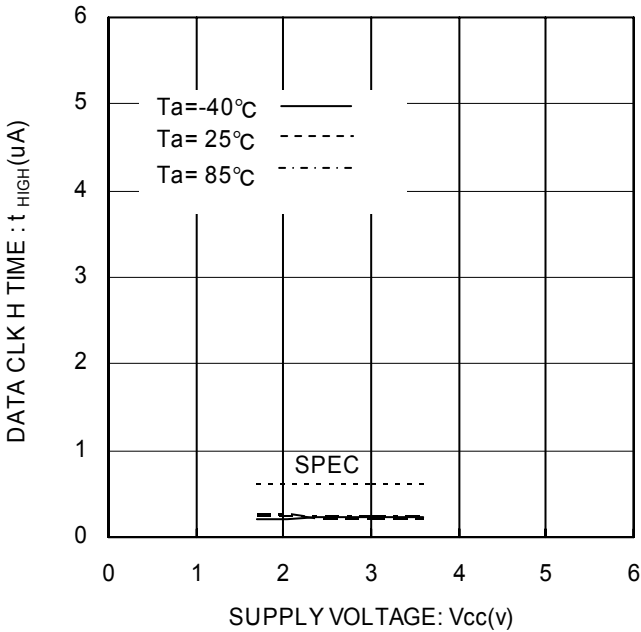


Figure 13. Data clock High Period t_{HIGH}

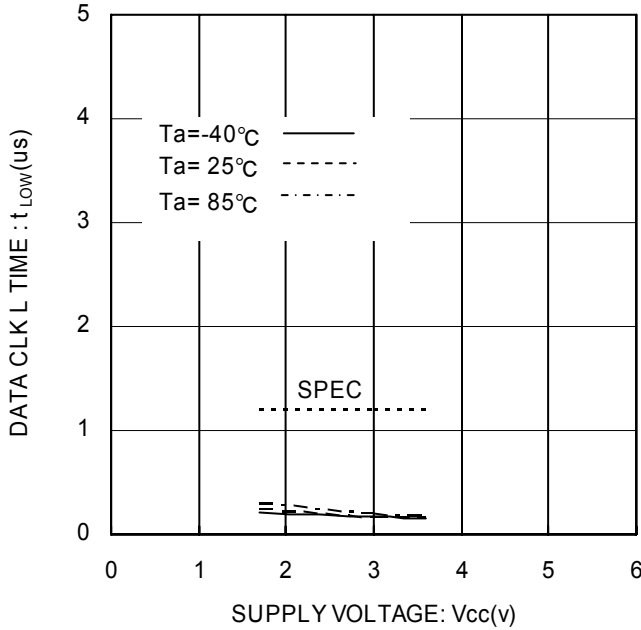


Figure 14. Data clock Low Period t_{LOW}

● Typical Performance Curves - Continued

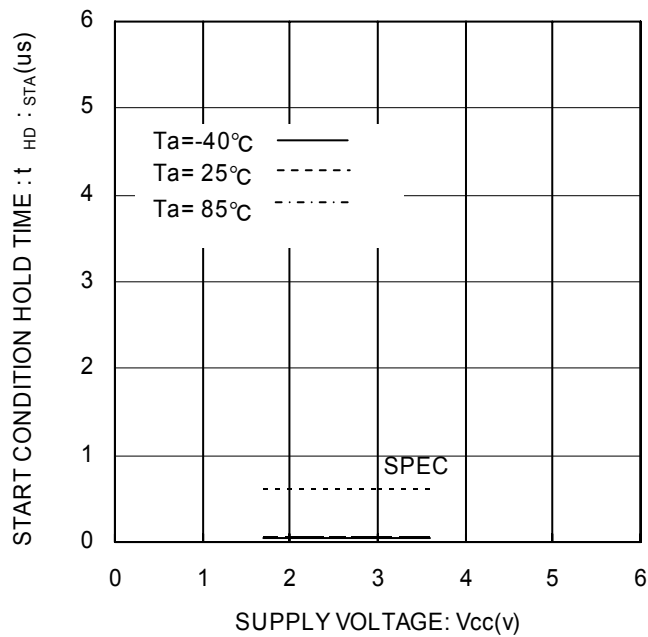


Figure 15. Start Condition Hold Time $t_{HD : STA}$

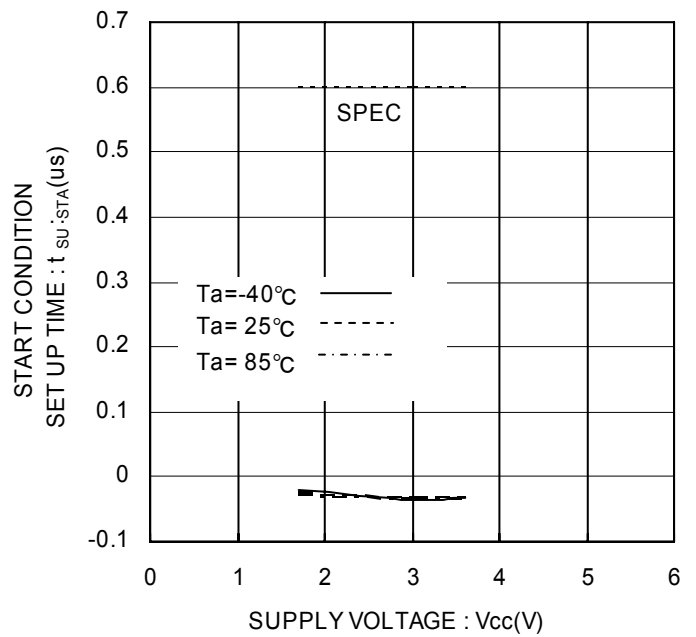


Figure 16. Start Condition Setup Time $t_{SU : STA}$

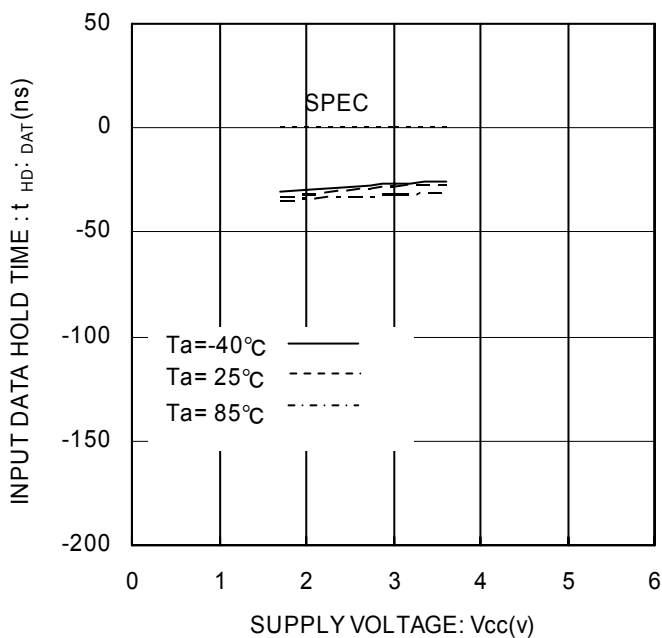


Figure 17. Input Data Hold Time $t_{HD : DAT}$

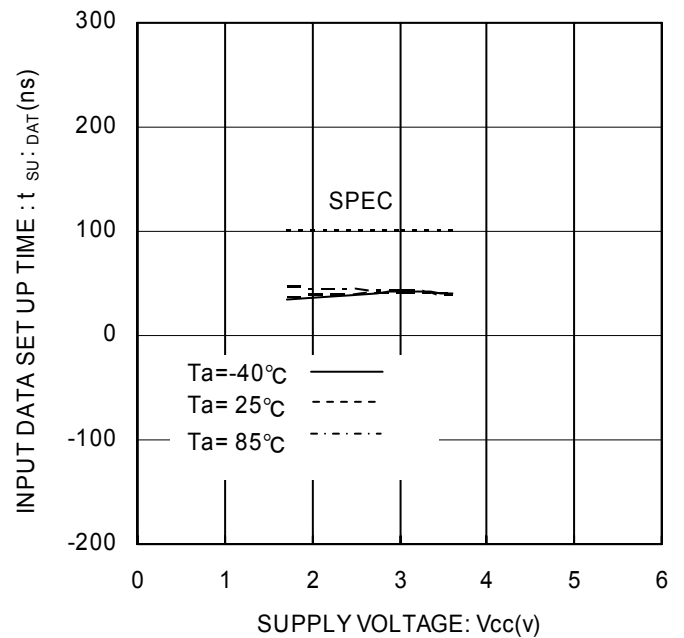


Figure 18. Input Data Setup Time $t_{SU : DAT}$

●Typical Performance Curves - Continued

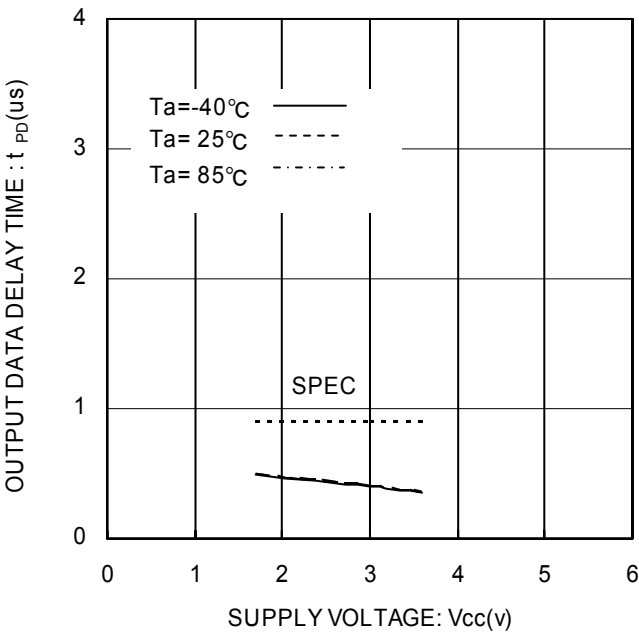


Figure 19. 'L' Data output delay time t_{PD0}

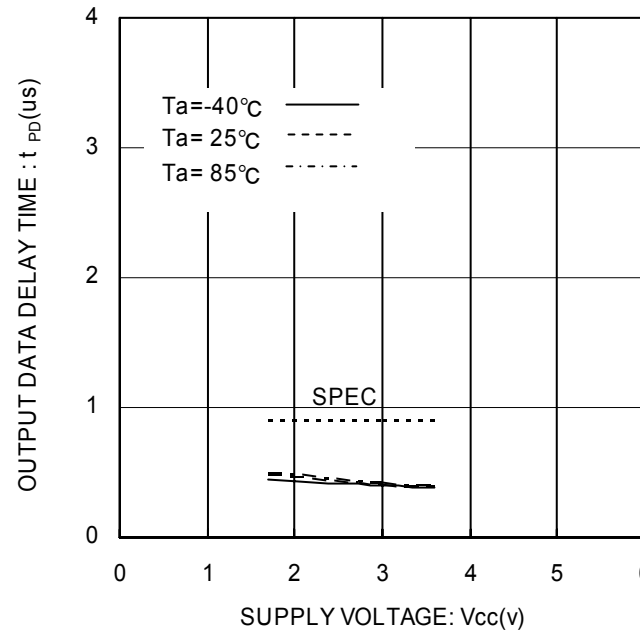


Figure 20. 'H' Data output delay time t_{PD1}

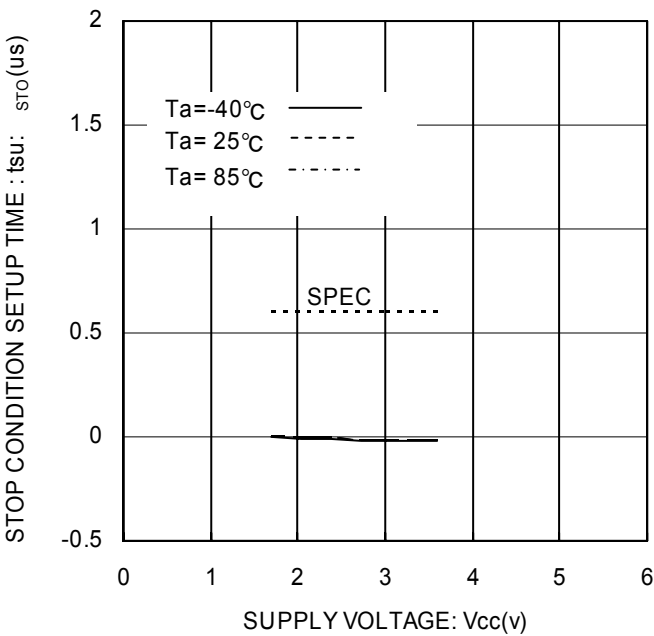


Figure 21. Stop Condition Setup Time $t_{SU:STO}$

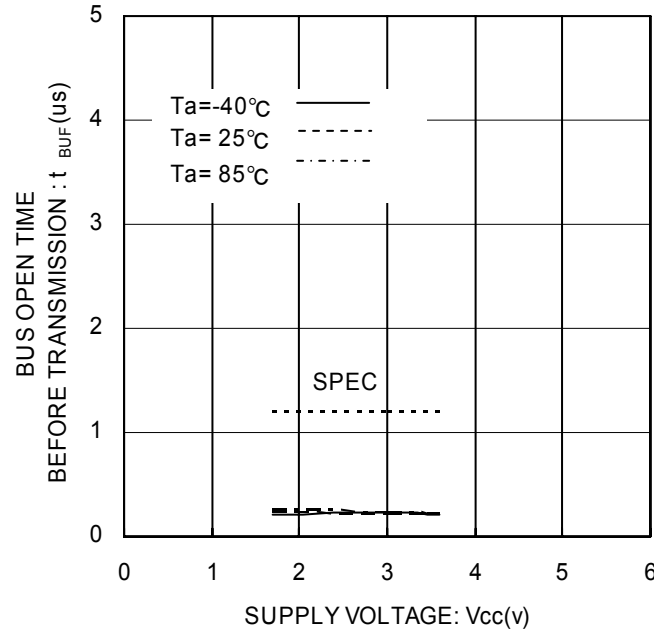


Figure 22. BUS open time before transmission t_{BUF}

●Typical Performance Curves - Continued

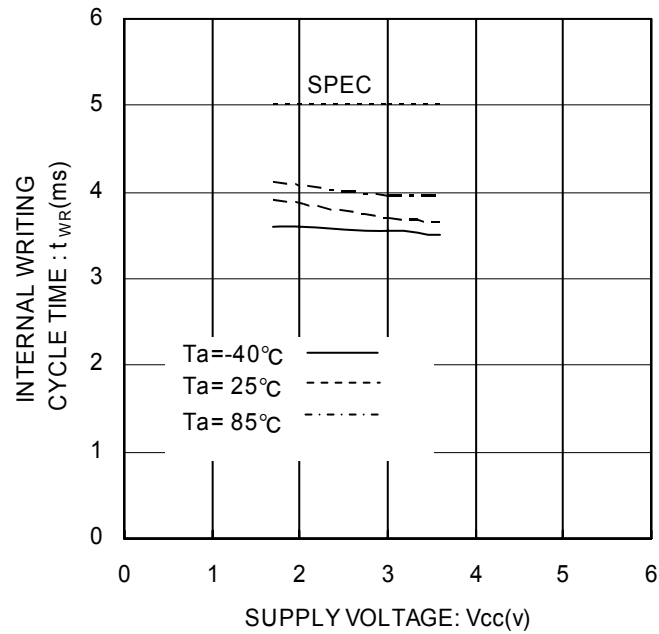


Figure 23. Internal writing cycle time t_{WR}

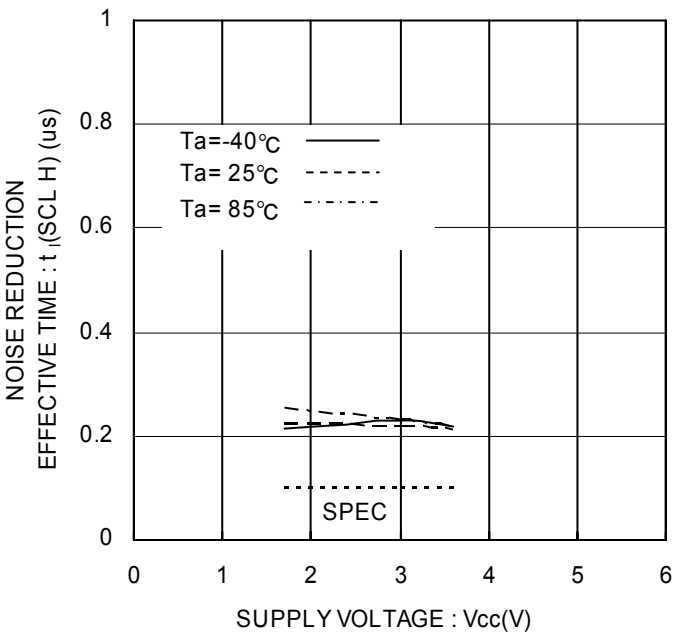


Figure 24. Noise reduction effective time t_l (SCL H)

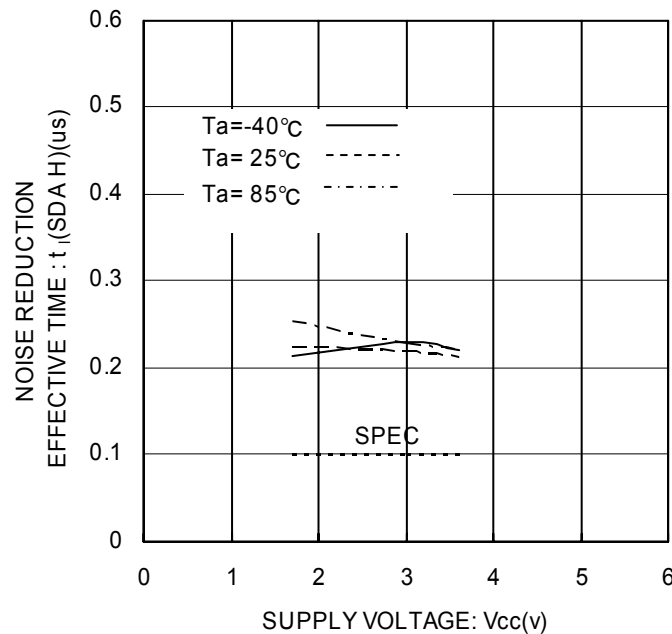


Figure 25. Noise reduction effective time t_l (SDA H)

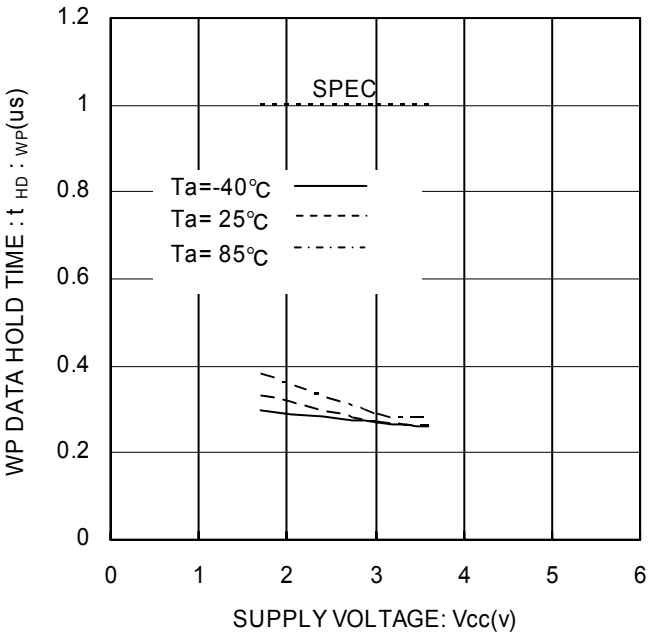


Figure 26. WP Hold Time $t_{HD} : WP$

●Typical Performance Curves - Continued

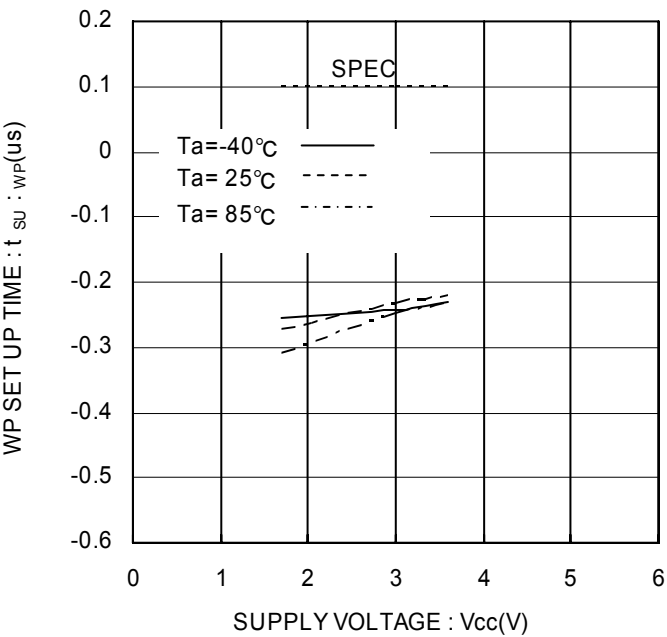


Figure 27. WP Setup Time $t_{SU:WP}$

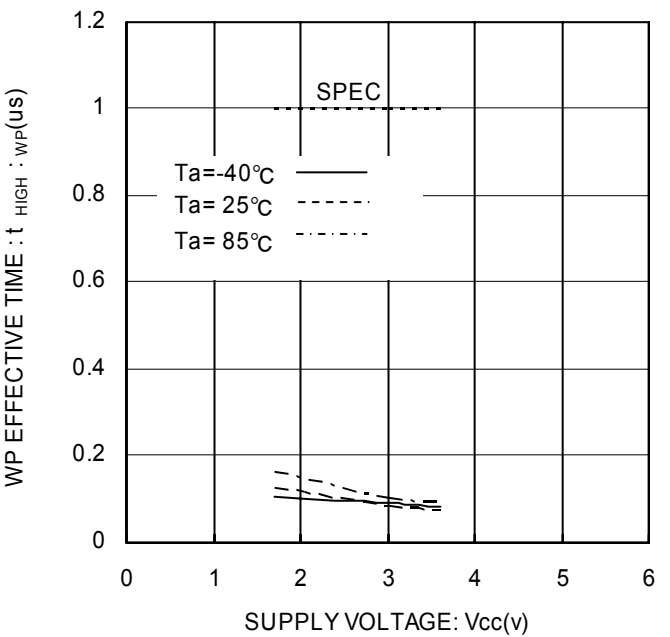


Figure 28. WP High Period $t_{HIGH:WP}$

● I²C BUS Communication

○ I²C BUS data communication

I²C BUS data communication starts by start condition input, and ends by stop condition input. Data is always 8bit long, and acknowledge is always required after each byte. I²C BUS carries out data transmission with plural devices connected by 2 communication lines of serial data (SDA) and serial clock (SCL).

Among devices, there are "master" that generates clock and control communication start and end, and "slave" that is controlled by address peculiar to devices. EEPROM becomes "slave". And the device that outputs data to bus during data communication is called "transmitter", and the device that receives data is called "receiver".

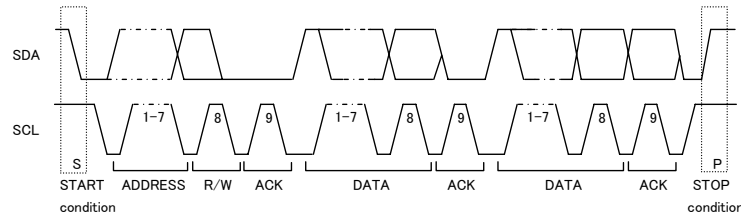


Figure 29. Data transfer timing

○ Start condition (Start bit recognition)

- Before executing each command, start condition (start bit) where SDA goes from 'HIGH' down to 'LOW' when SCL is 'HIGH' is necessary.
- This IC always detects whether SDA and SCL are in start condition (start bit) or not, therefore, unless this condition is satisfied, any command is executed.

○ Stop condition (stop bit recognition)

- Each command can be ended by SDA rising from 'LOW' to 'HIGH' when stop condition (stop bit), namely, SCL is 'HIGH'.

○ Acknowledge (ACK) signal

- This acknowledge (ACK) signal is a software rule to show whether data transfer has been made normally or not. In master and slave, the device (μ -COM at slave address input of write command, read command, and this IC at data output of read command) at the transmitter (sending) side releases the bus after output of 8bit data.
- The device (this IC at slave address input of write command, read command, and μ -COM at data output of read command) at the receiver (receiving) side sets SDA 'LOW' during 9 clock cycles, and outputs acknowledge signal (ACK signal) showing that it has received the 8bit data.
- This IC, after recognizing start condition and slave address (8bit), outputs acknowledge signal (ACK signal) 'LOW'.
- Each write action outputs acknowledge signal (ACK signal) 'LOW', at receiving 8bit data (word address and write data).
- Each read action outputs 8bit data (read data), and detects acknowledge signal (ACK signal) 'LOW'. When acknowledge signal (ACK signal) is detected, and stop condition is not sent from the master (μ -COM) side, this IC continues data output. When acknowledge signal (ACK signal) is not detected, this IC stops data transfer, and recognizes stop condition (stop bit), and ends read action. And this IC gets in status.

○ Device addressing

- Output slave address after start condition from master.
- The significant 4 bits of slave address are used for recognizing a device type.
The device code of this IC is fixed to '1010'.
- Next slave addresses (P2, P1, P0 --- page select) are for selecting page addresses.
- The most insignificant bit (R/\overline{W} --- READ / WRITE) of slave address is used for designating write or read action, and is as shown below.

Setting R/\overline{W} to 0 ----- write (setting 0 to word address setting of random read)

Setting R/\overline{W} to 1 ----- read

Type	Slave address
BRCC016GWX-3	1 0 1 0 P2 P1 P0 R/\overline{W}

●Write Command

○Write cycle

- Arbitrary data is written to EEPROM. When to write only 1 byte, byte write is normally used, and when to write continuous data of 2 bytes or more, simultaneous write is possible by page write cycle. Up to 16 arbitrary bytes can be written.

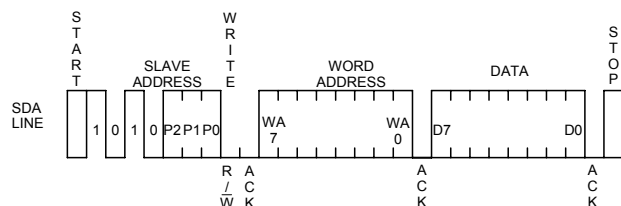


Figure 30. Byte write cycle

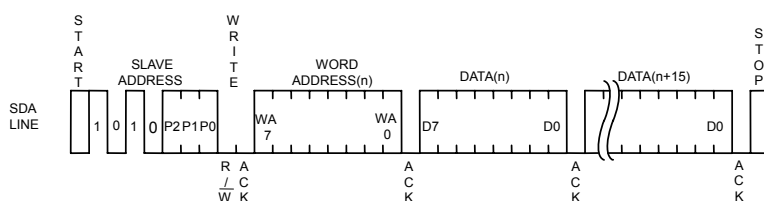


Figure 31. Page write cycle

- During internal write execution, all input commands are ignored, therefore ACK is not sent back.
- Data is written to the address designated by word address (n-th address)
- By issuing stop bit after 8bit data input, write to memory cell inside starts.
- When internal write is started, command is not accepted for tWR (5ms at maximum).
- By page write cycle, the following can be written in bulk : Up to 16Byte

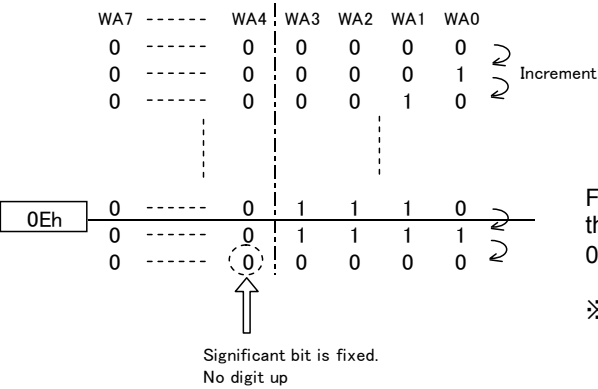
And when data of the maximum bytes or higher is sent, data from the first byte is overwritten.
(Refer to "Internal address increment" of "Notes on page write cycle" in P14.)

- As for page write command, after page select bit 'P0,P1,P2' of slave address are designated arbitrarily, by continuing data input of 2 bytes or more, the address of insignificant 4 bits is incremented internally, and data up to 16 bytes can be written.

Notes on page write cycle

1 page=16bytes, but the page
write cycle time is 5ms at maximum for 16byte bulk write.
It does not stand 5ms at maximum × 16byte=80ms(Max.)

Internal address increment
Page write mode



For example, when it is started from address 0Eh,
therefore, increment is made as below,
0Eh→0Fh→00h→01h... which please note.

※0Eh...0E in hexadecimal, therefore,
00001110 becomes a binary number.

Write protect (WP) terminal
• Write protect (WP) function

When WP terminal is set Vcc (H level), data rewrite of all addresses is prohibited. When it is set GND (L level), data rewrite of all address is enabled. WP pin has a Pull-up resistor. Please be left unconnected or connect to Vcc, or control it to H level when WP feature is in use. And be sure to connect to GND, or control it to L level when WP feature is not in use.
At extremely low voltage at power ON / OFF, by setting the WP terminal 'H', mistake write can be prevented.

●Read Command

○Read cycle

Data of EEPROM is read. In read cycle, there are random read cycle and current read cycle. Random read cycle is a command to read data by designating address, and is used generally. Current read cycle is a command to read data of internal address register without designating address, and is used when to verify just after write cycle. In both the read cycles, sequential read cycle is available, and the next address data can be read in succession.

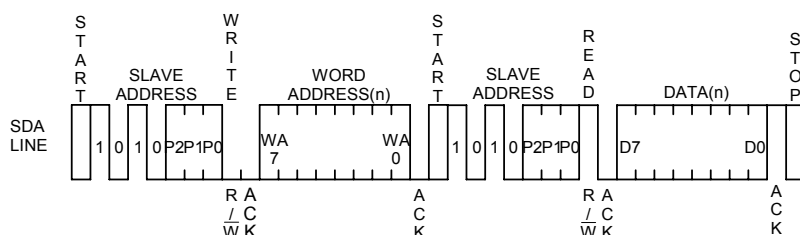


Figure 32. Random read cycle

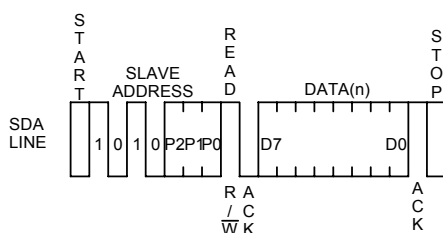


Figure 33. Current read cycle

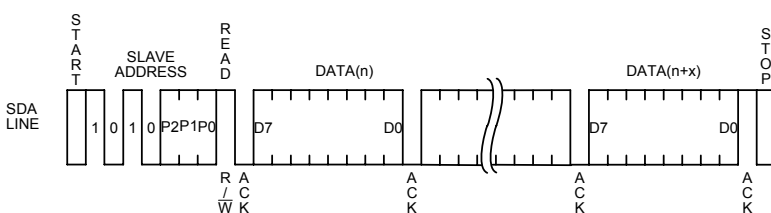


Figure 34. Sequential read cycle (in the case of current read cycle)

- In random read cycle, data of designated word address can be read.
- When the command just before current read cycle is random read cycle, current read cycle (each including sequential read cycle), data of incremented last read address (n)-th address, i.e., data of the (n+1)-th address is output.
- When ACK signal 'LOW' after D0 is detected, and stop condition is not sent from master (μ -COM) side, the next address data can be read in succession.
- Read cycle is ended by stop condition where 'H' is input to ACK signal after D0 and SDA signal is started at SCL signal 'H'.
- When 'H' is not input to ACK signal after D0, sequential read gets in, and the next data is output. Therefore, read command cycle cannot be ended. When to end read command cycle, be sure input stop condition to input 'H' to ACK signal after D0, and to start SDA at SCL signal 'H'.
- Sequential read is ended by stop condition where 'H' is input to ACK signal after arbitrary D0 and SDA is started at SCL signal 'H'.

● Software Reset

Software reset is executed when to avoid malfunction after power on, and to reset during command input. Software reset has several kinds, and 3 kinds of them are shown in the figure below. (Refer to Figure 35-(a), Figure 35-(b), Figure 35-(c).) In dummy clock input area, release the SDA bus ('H' by pull up). In dummy clock area, ACK output and read data '0' (both 'L' level) may be output from EEPROM, therefore, if 'H' is input forcibly, output may conflict and over current may flow, leading to instantaneous power failure of system power source or influence upon devices.

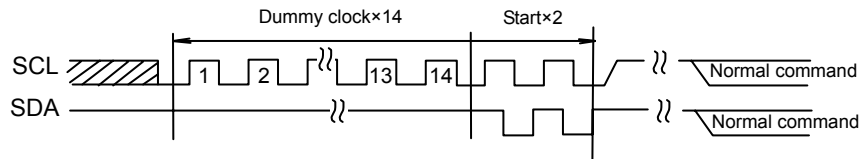


Figure 35-(a). The case of dummy clock×14 + START+START+ command input

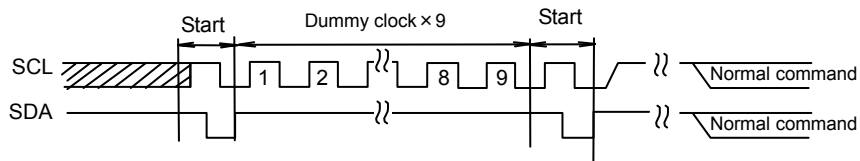


Figure 35-(b). The case of START + dummy clock×9 + START + command input

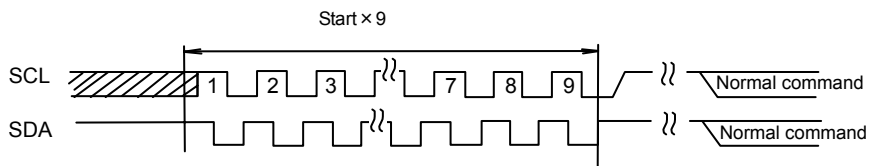


Figure 35-(c). START×9 + command input

※Start command from START input.

● Acknowledge Polling

During internal write execution, all input commands are ignored, therefore ACK is not sent back. During internal automatic write execution after write cycle input, next command (slave address) is sent, and if the first ACK signal sends back 'L', then it means end of write action, while if it sends back 'H', it means now in writing. By use of acknowledge polling, next command can be executed without waiting for $t_{WR} = 5\text{ms}$.

When to write continuously, $R/\bar{W} = 0$, when to carry out current read cycle after write, slave address $R/\bar{W} = 1$ is sent, and if ACK signal sends back 'L', then execute word address input and data output and so forth.

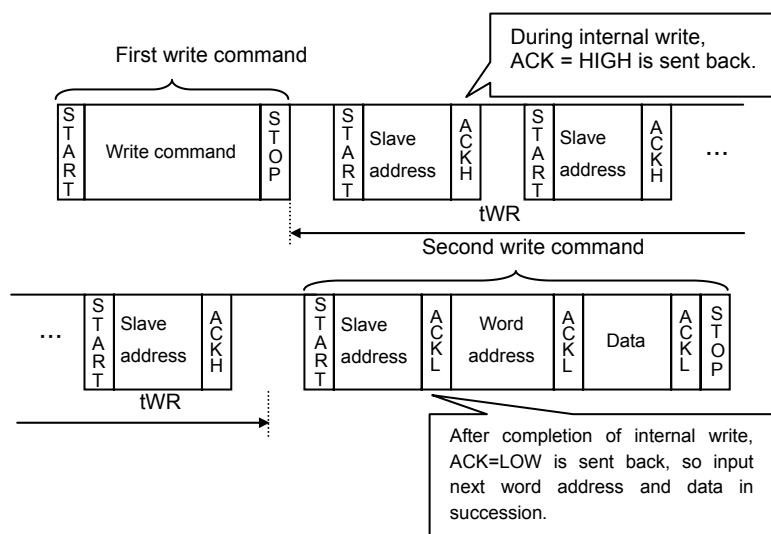


Figure 36. Case to continuously write by acknowledge polling

●WP Valid Timing (Write Cancel)

WP is usually fixed to 'H' or 'L', but when WP is used to cancel write cycle and so forth, pay attention to the following WP valid timing. During write cycle execution, in cancel valid area, by setting WP='H', write cycle can be cancelled. In both byte write cycle and page write cycle, the area from the first start condition of command to the rise of clock to taken in D0 of data(in page write cycle, the first byte data) is cancel invalid area.

WP input in this area becomes Don't care. The area from the rise of SCL to take in D0 to input the stop condition is cancel valid area. And, after execution of forced end by WP, standby status gets in.

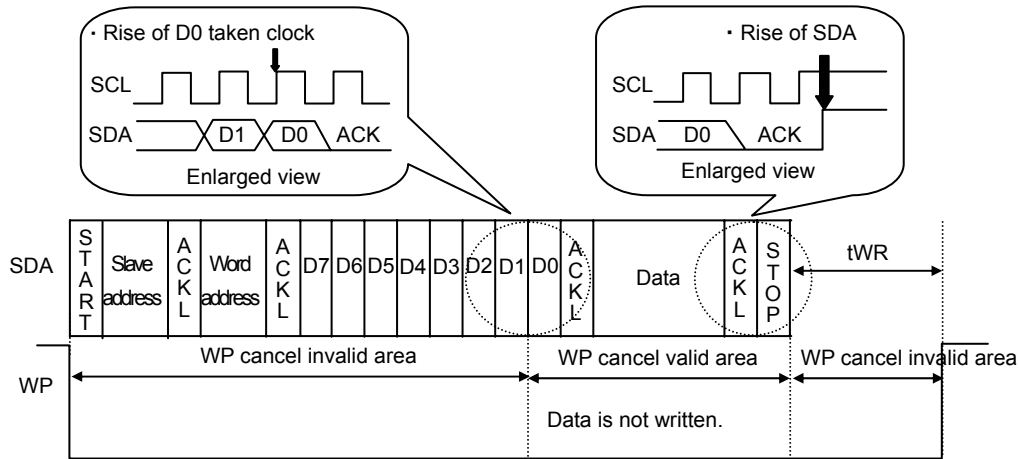


Figure 37. WP valid timing

●Command Cancel by Start Condition and Stop Condition

During command input, by continuously inputting start condition and stop condition, command can be cancelled. (Figure 38) However, in ACK output area and during data read, SDA bus may output 'L', and in this case, start condition and stop condition cannot be input, so reset is not available. Therefore, execute software reset. And when command is cancelled by start, stop condition, during random read cycle, sequential read cycle, or current read cycle, internal setting address is not determined, therefore, it is not possible to carry out current read cycle in succession. When to carry out read cycle in succession, carry out random read cycle.

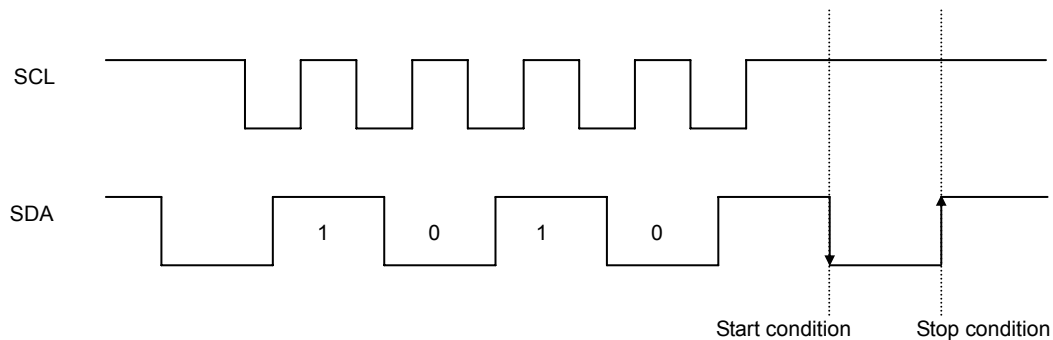


Figure 38. Case of cancel by start, stop condition during slave address input

●I/O Peripheral Circuit

○Pull up resistance of SDA terminal

SDA is NMOS open drain, so requires pull up resistance. As for this resistance value (R_{PU}), select an appropriate value to this resistance value from microcontroller V_{IL} , I_L , and $V_{OL}-I_{OL}$ characteristics of this IC. If R_{PU} is large, action frequency is limited. The smaller the R_{PU} , the larger the consumption current at action.

○Maximum value of R_{PU}

The maximum value of R_{PU} is determined by the following factors.

①SDA rise time to be determined by the capacitance (CBUS) of bus line of R_{PU} and SDA should be t_R or below.

And AC timing should be satisfied even when SDA rise time is late.

②The bus electric potential (A) to be determined by input leak total (I_L) of device connected to bus at output of 'H' to SDA bus and R_{PU} should sufficiently secure the input 'H' level (V_{IH}) of microcontroller and EEPROM including recommended noise margin $0.2V_{CC}$.

$$V_{CC} - I_L R_{PU} - 0.2 V_{CC} \geq V_{IH}$$

$$\therefore R_{PU} \leq \frac{0.8 V_{CC} - V_{IH}}{I_L}$$

Ex.) $V_{CC}=3V$ $I_L=10\mu A$ $V_{IH}=0.7 V_{CC}$
from ②

$$R_{PU} \leq \frac{0.8 \times 3 - 0.7 \times 3}{10 \times 10^{-6}} \\ \leq 30 [k\Omega]$$

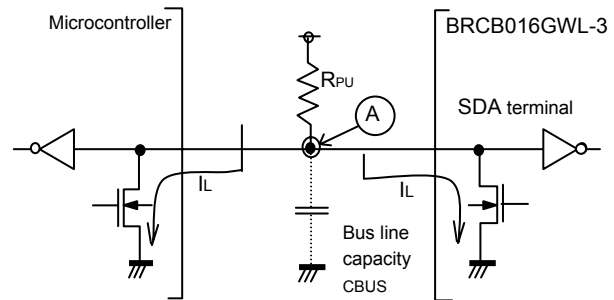


Figure 39. I/O circuit diagram

○ Minimum value of R_{PU}

The minimum value of R_{PU} is determined by the following factors.

When IC outputs LOW, it should be satisfied that $V_{OLMAX}=0.4V$ and $I_{OLMAX}=3mA$.

$$\frac{V_{CC} V_{OL}}{I_{OL}} \leq I_{OL}$$

$$\therefore R_{PU} \geq \frac{V_{CC} - V_{OL}}{I_{OL}}$$

② $V_{OLMAX}=0.4V$ should secure the input 'L' level (V_{IL}) of microcontroller and EEPROM including recommended noise margin $0.1V_{CC}$.

$$V_{OLMAX} \leq V_{IL} - 0.1 V_{CC}$$

Ex.) $V_{CC}=3V$, $V_{OL}=0.4V$, $I_{OL}=3mA$, microcontroller, EEPROM $V_{IL}=0.3V_{CC}$

$$\text{from ①} \quad R_{PU} \geq \frac{3 - 0.4}{3 \times 10^{-3}} \\ \geq 867 [\Omega]$$

$$\text{And} \quad V_{OL}=0.4 [V] \\ V_{IL}=0.3 \times 3 \\ =0.9 [V]$$

Therefore, the condition ② is satisfied.

○Pull up resistance of SCL terminal

When SCL control is made at CMOS output port, there is no need, but in the case there is timing where SCL becomes 'Hi-Z', add a pull up resistance. As for the pull up resistance, one of several $k\Omega$ to several ten $k\Omega$ is recommended in consideration of drive performance of output port of microcontroller.

●Process of WP terminal

WP terminal is the terminal that prohibits and permits write in hardware manner. In 'H' status, only READ is available and WRITE of all address is prohibited. In the case of 'L', both are available. In the case of use it as an ROM, it is recommended to connect it to pull up or V_{CC} or open. In the case to use both READ and WRITE, control WP terminal or connect it to pull down or GND.

●Cautions on Microcontroller Connection

ORs

In I²C BUS, it is recommended that SDA port is of open drain input/output. However, when to use CMOS input / output of tri state to SDA port, insert a series resistance R_s between the pull up resistance R_{PU} and the SDA terminal of EEPROM. This is controls over current that occurs when PMOS of the microcontroller and NMOS of EEPROM are turned ON simultaneously. R_s also plays the role of protection of SDA terminal against surge. Therefore, even when SDA port is open drain input/output, R_s can be used.

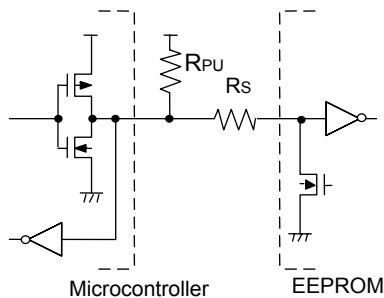


Figure 40. I/O circuit diagram

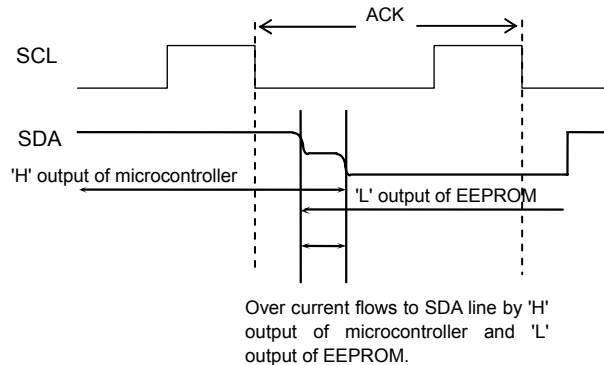


Figure 41. Input / output collision timing

OMaximum value of R_s

The maximum value of R_s is determined by the following relations.

- ① SDA rise time to be determined by the capacity (CBUS) of bus line of R_{PU} and SDA should be t_R or below. And AC timing should be satisfied even when SDA rise time is late.
- ② The bus electric potential (A) to be determined by R_{PU} and R_s the moment when EEPROM outputs 'L' to SDA bus sufficiently secure the input 'L' level (V_{IL}) of microcontroller including recommended noise margin $0.1V_{CC}$.

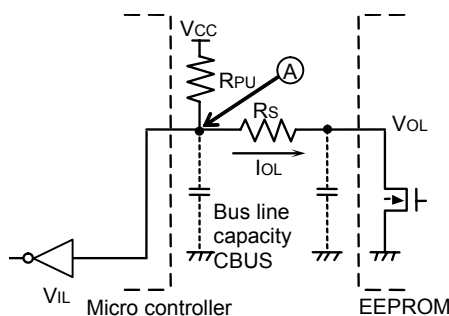


Figure 42. I/O Circuit Diagram

$$\frac{(V_{CC} - V_{OL}) \times R_s}{R_{PU} + R_s} + V_{OL} + 0.1V_{CC} \leq V_{IL}$$

$$\therefore R_s \leq \frac{V_{IL} - V_{OL} - 0.1V_{CC}}{1.1V_{CC} - V_{IL}} \times R_{PU}$$

$$\text{EX) } V_{CC} = 3V \quad V_{IL} = 0.3V_{CC} \quad V_{OL} = 0.4V \quad R_{PU} = 20k\Omega$$

$$R_s \leq \frac{0.3 \times 3 - 0.4 - 0.1 \times 3}{1.1 \times 3 - 0.3 \times 3} \times 20 \times 10^3$$

$$\leq 1.67[k\Omega]$$

OMinimum value of R_s

The minimum value of R_s is determined by over current at bus collision. When over current flows, noises in power source line, and instantaneous power failure of power source may occur. When allowable over current is defined as I , the following relation must be satisfied. Determine the allowable current in consideration of impedance of power source line in set and so forth. Set the over current to EEPROM 10mA or below.

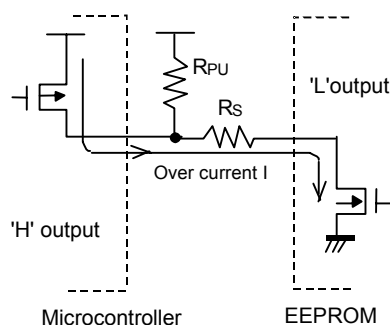


Figure 43. I/O circuit diagram

$$\frac{V_{CC}}{R_s} \leq I$$

$$\therefore R_s \geq \frac{V_{CC}}{I}$$

$$\text{EX) } V_{CC} = 3V \quad I = 10mA$$

$$R_s \geq \frac{3}{10 \times 10^{-3}}$$

$$\geq 300[\Omega]$$

● I²C BUS Input / Output Circuit

○ Input (WP)

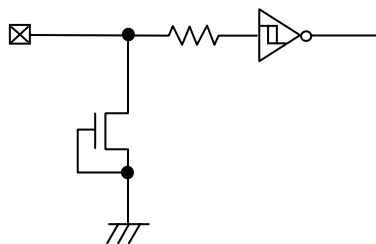


Figure 44(a). Input pin circuit diagram

○ Input (WP)

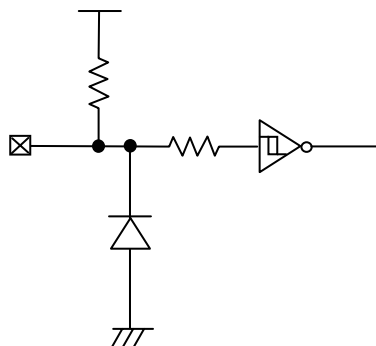


Figure 44(b). Input pin circuit diagram

○ Input / output (SDA)

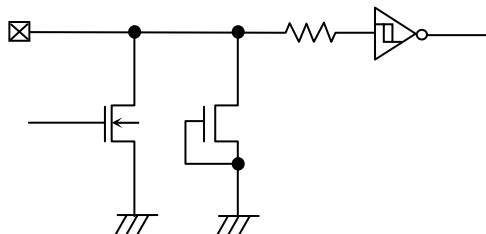


Figure 45. Input / output pin circuit diagram

● Unavailable command

The most significant four bits of slave address (devices code) are "1010" for this EEPROM.
And device code "1011" is prohibited to use, because it is used to test mode.
(When set WP = 'H', test mode is canceled to prevent malfunction.)

●Notes on Power ON

At power on, in IC internal circuit and set, Vcc rises through unstable low voltage area, and IC inside is not completely reset, and malfunction may occur. To prevent this, functions of POR circuit and LVCC circuit are equipped. To assure the action, observe the following conditions at power on.

1. Set SDA = 'H' and SCL = 'L' or 'H'
2. Start power source so as to satisfy the recommended conditions of t_R , t_{OFF} , and V_{bot} for operating POR circuit.

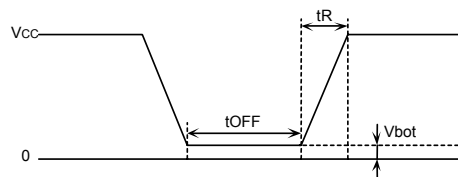


Figure 46. Rise waveform diagram

Recommended conditions of t_R , t_{OFF} , V_{bot}

t_R	t_{OFF}	V_{bot}
10ms or below	10ms or larger	0.3V or below
100ms or below	10ms or larger	0.2V or below

3. Set SDA and SCL so as not to become 'Hi-Z'.

When the above conditions 1 and 2 cannot be observed, take the following countermeasures.

- a) In the case when the above condition 1 cannot be observed. When SDA becomes 'L' at power on.
→Control SCL and SDA as shown below, to make SCL and SDA, 'H' and 'H'.

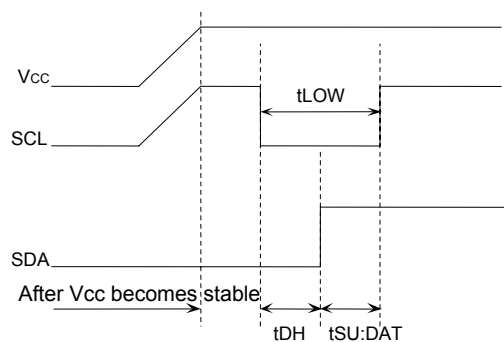


Figure 47. When SCL= 'H' and SDA= 'L'

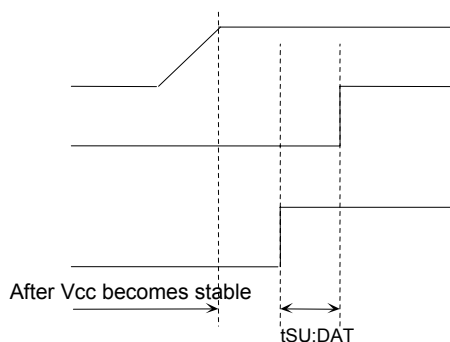


Figure 48. When SCL='L' and SDA='L'

- b) In the case when the above condition 2 cannot be observed.
→After power source becomes stable, execute software reset(P16).
- c) In the case when the above conditions 1 and 2 cannot be observed.
→Carry out a), and then carry out b).

●Low Voltage Malfunction Prevention Function

LVCC circuit prevents data rewrite action at low power, and prevents wrong write. At LVCC voltage (Typ. =1.2V) or below, it prevent data rewrite.

●Vcc Noise Countermeasures

○Bypass capacitor

When noise or surge gets in the power source line, malfunction may occur, therefore, for removing these, it is recommended to attach a bypass capacitor (0.1μF) between IC Vcc and GND. At that moment, attach it as close to IC as possible. And, it is also recommended to attach a bypass capacitor between board Vcc and GND.

●Notes for Use

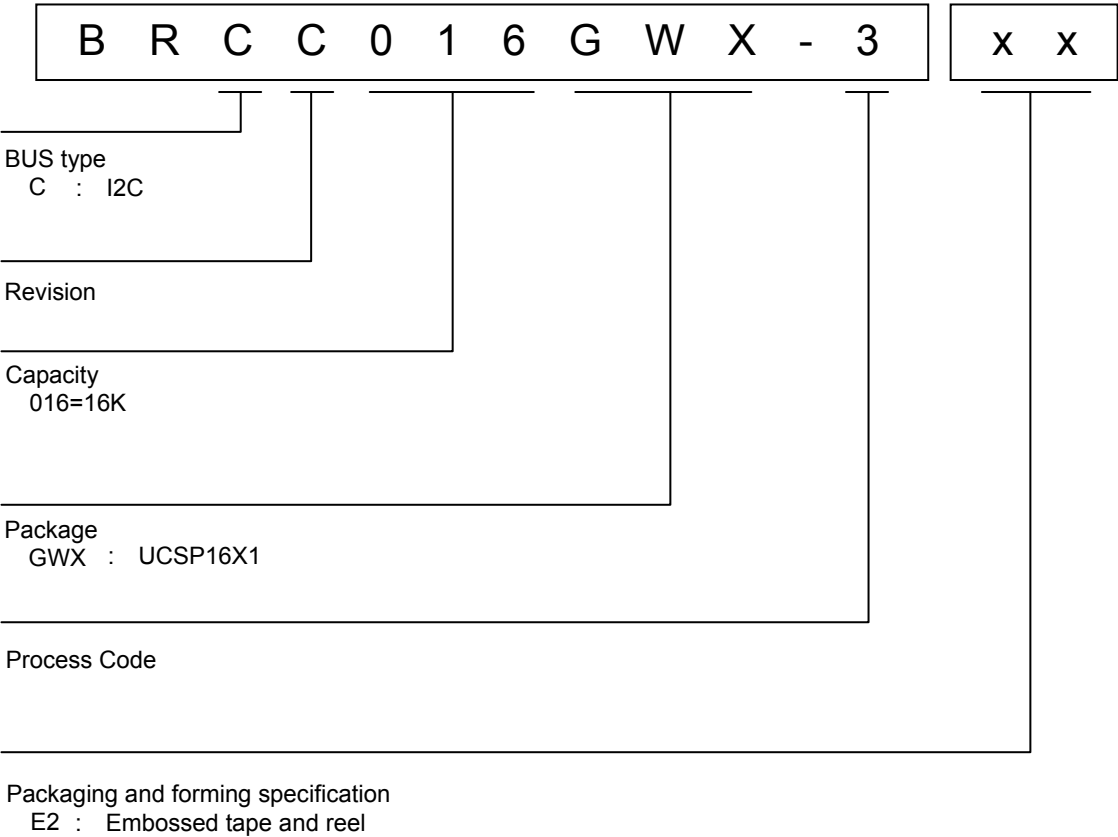
- (1) Described numeric values and data are design representative values, and the values are not guaranteed.
- (2) We believe that application circuit examples are recommendable, however, in actual use, confirm characteristics further sufficiently. In the case of use by changing the fixed number of external parts, make your decision with sufficient margin in consideration of static characteristics and transition characteristics and fluctuations of external parts and our LSI.
- (3) Absolute maximum ratings
If the absolute maximum ratings such as impressed voltage and action temperature range and so forth are exceeded, LSI may be destructed. Do not impress voltage and temperature exceeding the absolute maximum ratings. In the case of fear exceeding the absolute maximum ratings, take physical safety countermeasures such as fuses, and see to it that conditions exceeding the absolute maximum ratings should not be impressed to LSI.
- (4) GND electric potential
Set the voltage of GND terminal lowest at any action condition. Make sure that each terminal voltage is lower than that of GND terminal.
- (5) Terminal design
In consideration of permissible loss in actual use condition, carry out heat design with sufficient margin.
- (6) Terminal to terminal short-circuit and wrong packaging
When to package LSI onto a board, pay sufficient attention to LSI direction and displacement. Wrong packaging may destruct LSI. And in the case of short-circuit between LSI terminals and terminals and power source, terminal and GND owing to foreign matter, LSI may be destructed.
- (7) Use in a strong electromagnetic field may cause malfunction, therefore, evaluate design sufficiently.

Status of this document

The Japanese version of this document is formal specification. A customer may use this translation version only for a reference to help reading the formal version.

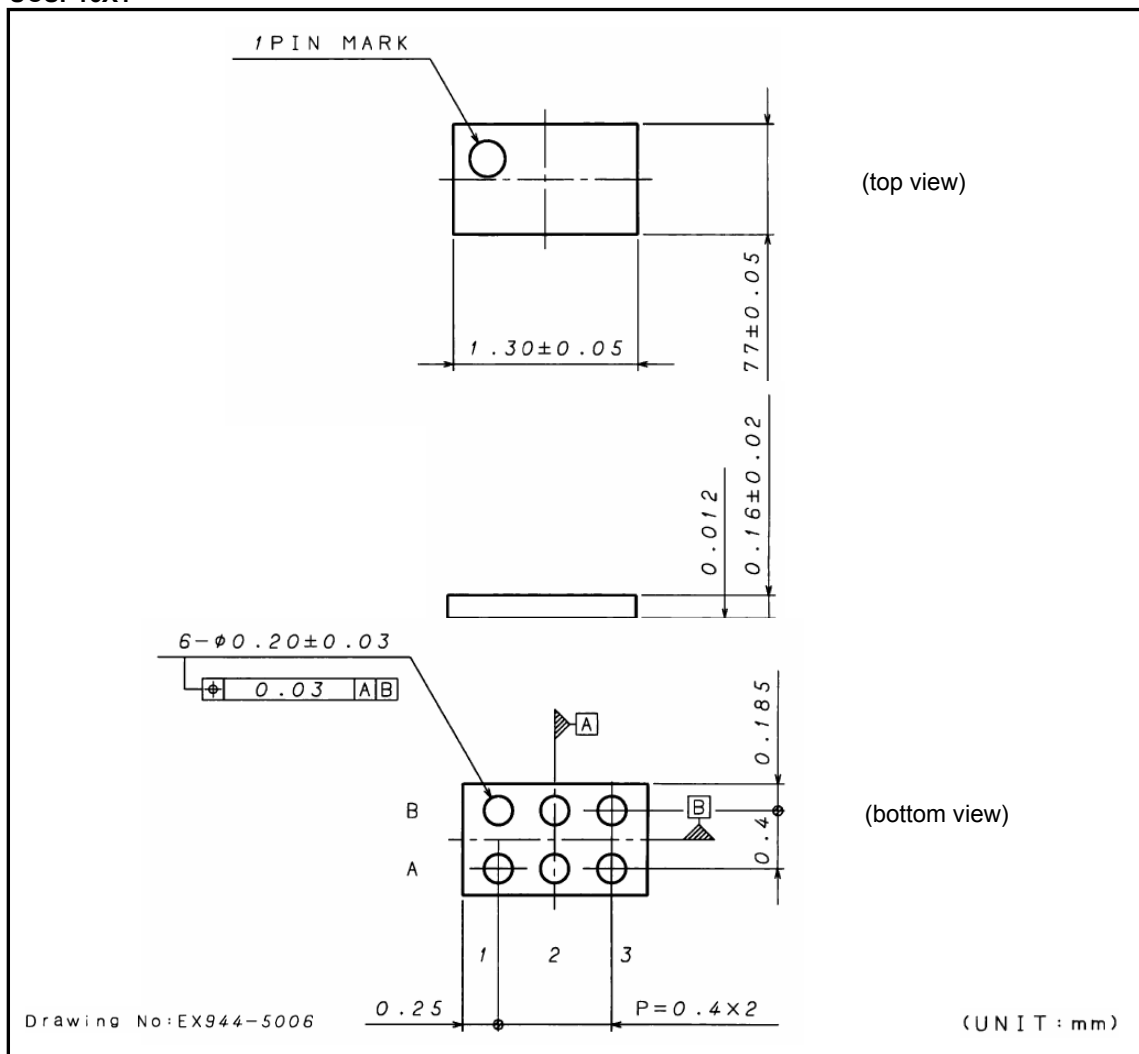
If there are any differences in translation version of this document formal version takes priority.

●Ordering Information Product Code Description



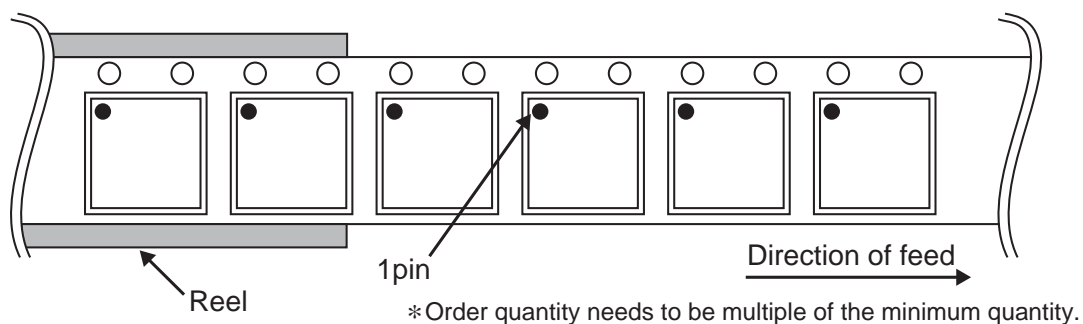
●Physical Dimensions Tape and Reel Information

UCSP16X1

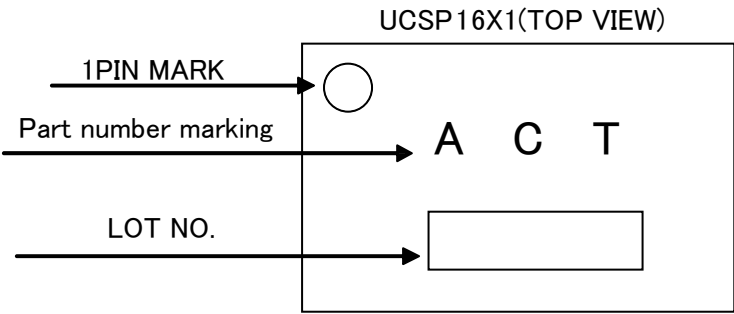


<Tape and Reel information>

Tape	Embossed carrier tape
Quantity	3000pcs
Direction of feed	E2 (The direction is the 1pin of product is at the upper left when you hold reel on the left hand and you pull out the tape on the right hand)



●Marking Diagrams



●Revision History

Date	Revision	Changes
03.Sep.2012	001	New Release

Notice

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 - [c] Use of our Products in places where the Products are exposed to sea wind or corrosive gases, including Cl₂, H₂S, NH₃, SO₂, and NO₂
 - [d] Use of our Products in places where the Products are exposed to static electricity or electromagnetic waves
 - [e] Use of our Products in proximity to heat-producing components, plastic cords, or other flammable items
 - [f] Sealing or coating our Products with resin or other coating materials
 - [g] Use of our Products without cleaning residue of flux (even if you use no-clean type fluxes, cleaning residue of flux is recommended); or Washing our Products by using water or water-soluble cleaning agents for cleaning residue after soldering
 - [h] Use of the Products in places subject to dew condensation
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- 6) In particular, if a transient load (a large amount of load applied in a short period of time, such as pulse) is applied, confirmation of performance characteristics after on-board mounting is strongly recommended. Avoid applying power exceeding normal rated power; exceeding the power rating under steady-state loading condition may negatively affect product performance and reliability.
- 7) De-rate Power Dissipation (Pd) depending on Ambient temperature (Ta). When used in sealed area, confirm the actual ambient temperature.
- 8) Confirm that operation temperature is within the specified range described in the product specification.
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- 2) In principle, the reflow soldering method must be used; if flow soldering method is preferred, please consult with the ROHM representative in advance.

For details, please refer to ROHM Mounting specification

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This Product is electrostatic sensitive product, which may be damaged due to electrostatic discharge. Please take proper caution in your manufacturing process and storage so that voltage exceeding the Products maximum rating will not be applied to Products. Please take special care under dry condition (e.g. Grounding of human body / equipment / solder iron, isolation from charged objects, setting of Ionizer, friction prevention and temperature / humidity control).

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 - [b] the temperature or humidity exceeds those recommended by ROHM
 - [c] the Products are exposed to direct sunshine or condensation
 - [d] the Products are exposed to high Electrostatic
- 2) Even under ROHM recommended storage condition, solderability of products out of recommended storage time period may be degraded. It is strongly recommended to confirm solderability before using Products of which storage time is exceeding the recommended storage time period.
- 3) Store / transport cartons in the correct direction, which is indicated on a carton with a symbol. Otherwise bent leads may occur due to excessive stress applied when dropping of a carton.
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